

<b>Notice of References Cited</b>	Application/Control No. 10/669,521	Applicant(s)/Patent Under Reexamination ONEYAMA ET AL.	
	Examiner Lisa Lea-Edmonds	Art Unit 2835	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0009498	07-2001	Oross et al.	361/681
	B	US-6,262,824 B1	07-2001	Sasaki et al.	398/115
	C	US-5,701,230	12-1997	Liang et al.	361/681
	D	US-5,870,282 A	02-1999	Andre et al.	361/683
	E	US-6,262,886 B1	07-2001	DiFonzo et al.	361/683
	F	US-6,421,235 B2	07-2002	Ditzik, Richarad J.	361/683
	G	US-6,504,707 B2	01-2003	Agata et al.	361/681
	H	US-6,842,338 B2	01-2005	Iredale, Richard J.	361/683
	I	US-6,301,100 B1	10-2001	Iwata, Yasuo	361/683
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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